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WHAT IS CLAIMED IS:

1. A method of precharging a bank of memory cells in a semiconductor memory device, the method comprising:

receiving a command that includes an auto-precharge function to the semiconductor memory device;

initiating a timer in response to the received command; and automatically precharging the bank responsive to the timer reaches a predetermined value.

- 2. The method of Claim 1, wherein the received command is associated with data stored in a specific row of the bank, and wherein the method further comprises resetting the timer when prior to the timer reaching the predetermined value a second command is received by the semiconductor memory device that is associated with additional data stored in the specific row of the bank.
 - 3. The method of Claim 1, wherein the received command is associated with data stored in a specific row of the bank, and wherein the method further comprises precharging the bank when prior to the timer reaching the predetermined value a second command is received by the semiconductor memory device that is associated with data stored in a different row of the bank.
 - 4. The method of Claim 1, wherein the received command is associated with data stored in a specific row of the bank, and wherein the specific row of the bank is left open for a period of time after an operation associated with the command is completed.
 - 5. The method of Claim 4, wherein the received command is a first read command, and wherein the method further comprises performing a first read operation in response to the first read command and performing a second read operation after completion of the first read operation using a page mode operation.
 - 6. The method of Claim 1, the method further comprising initiating a second timer in response to the received command and storing a row address associated with the received command.

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- 7. A semiconductor memory device, comprising:

 a memory cell array arranged in rows and columns; and $\sqrt{}$ a precharge control circuit having at least one timer, wherein the precharge control circuit is configured to issue a precharge control signal to the memory cell array responsive to receipt of a command that includes an auto-precharge function a predetermined time after the command is received.
 - 8. The semiconductor memory device of Claim 7, wherein the precharge control circuit issues an auto-precharge control signal to the memory cell array responsive to the at least one timer reaching the predetermined time.
 - 9. The semiconductor memory device of Claim 8, further comprising a storage device that stores the predetermined time.
 - 10. The semiconductor memory device of Claim 9, wherein the semiconductor memory device further comprises a second timer that measures passage of the predetermined auto-precharge time and a row address storage register that is associated with the second timer.
 - 11. The semiconductor memory device of Claim 7, further comprising a row decoder for decoding an externally received row address and a command decoder that activates an auto-precharge control signal in response to the input of a command having the auto-precharge function.
 - 12. A method of precharging a bank of memory cells in a semiconductor memory device, the method comprising:

receiving at the semiconductor memory device a read command that includes an auto-precharge function;

starting a timer responsive to receiving the received read command;
performing a read operation responsive to the received read command;
delaying initiation of an auto-precharge operation called for by the autoprecharge function until the timer reaches a predetermined time.

13. A method of reading data from a semiconductor memory device, the method comprising:

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receiving a read command that includes an auto-precharge function at the semiconductor memory device;

reading a first data bit from a cell in a first bank of cells in the semiconductor memory device in response to the received read command; and

using a page mode operation to read a second data bit from a second cell in the first bank of cells in the semiconductor memory device in response to a second read command.

- 14. The method of Claim 13, further comprising initiating a timer that measures an auto-precharge delay period in response to receiving the first read command.
- 15. The method of Claim 14, further comprising resetting the timer in response to the input of the second read command.
 - 16. A semiconductor memory device comprising:

 a memory cell array disposed in rows and columns;

 a row decoder for decoding an externally received row address;

a command decoder for decoding externally received commands and activating an auto-precharge control signal when a decoded command includes an auto-precharge function; and

a precharge control circuit that includes at least one timer that is reset in response to the auto-precharge control signal and that initiates precharging of at least a part of the memory cell array when the at least one timer reaches a predetermined value.

- 17. The semiconductor memory device of Claim 16, further comprising a program register that stores timing information about when the at least part of the memory cell array is precharged.
- 18. The semiconductor memory device of Claim 17, wherein the precharge control circuit causes the memory cell array to be precharged when the timer reaches a value of the timing information stored in the program register.
- 19. The semiconductor memory device of Claim 18, wherein the program30 register is a mode register set.

- 20. The semiconductor memory device of Claim 16, wherein the memory device is a DRAM device.
- 21. A semiconductor memory device comprising: 6
 a plurality of banks having a plurality of memory cells disposed in rows and
 5 columns;
 - a bank selector for selecting one of the banks in response to an externally received bank address;
 - a row selector for selecting one row of the selected bank in response to an externally received row address;
- a command decoder for decoding a externally received command and activating an auto-precharge control signal when the decoded command has an auto-precharge function; and
 - a precharge control circuit that includes a plurality of timers corresponding to the plurality of banks, respectively,
- wherein the timer corresponding to the selected bank is reset in response to auto-precharge control signal, and controls the bank to be precharged when the timer reaches a predetermined value.
 - 22. The semiconductor memory device of Claim 21, further comprising a program register that stores timing information regarding when the selected bank is precharged.
 - 23. The semiconductor memory device of Claim 22, wherein the precharge control circuit causes the selected bank to be precharged when the timer reaches a value of the timing information stored in the program register.
- 24. The semiconductor memory device of Claim 22, wherein the program register is mode register set.